

Notice of References Cited

Application/Control No.

09/218,411

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

Hanh Nguyen

Art Unit

2662

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6434395 B1	08-2002	Lubin et al.	455/466
	B	US-6430174 B1	08-2002	Jennings et al.	370/352
	C	US-5574773	11-1996	Grob et al.	455/466
	D	US-6047194	04-2000	Andersson	455/466
	E	US-6067529	05-2000	Ray et al.	455/466
	F	US-6061572	05-2000	Laiho	455/466
	G	US-6249811 B1	06-2001	Kido	709/219
	H	US-6366771 B1	04-2002	Angle et al.	455/414
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

A-R